



**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of:

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ANDREW J. KRIVY

Serial No. : 10/072,734

ART UNIT: 2829

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Examiner: KARLSEN, E.

For: METHOD FOR TESTING  
SEMICONDUCTOR WAFERS

Attorney Docket No. 96-750.3

**AMENDMENT**

**August 28, 2003**

Mail Stop Non Fee Amendment  
Commissioner For Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This Amendment is in response to the Office Action dated 06/11/2003, having a statutory period for response set to expire on 09/11/2003.